## Notice of References Cited Application/Control No. 10/534,541 Examiner MICHAEL R. VAUGHAN Applicant(s)/Patent Under Reexamination TSURUOKA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0063594 A1	04-2003	Li et al.	370/342
*	В	US-2004/0008676 A1	01-2004	Thomas, David Andrew	370/389
*	С	US-2004/0010619 A1	01-2004	Thomas, David Andrew	709/245
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
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	٦	US-			
	K	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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